

<b>Notice of References Cited</b>	Application/Control No. 10/773,804	Applicant(s)/Patent Under Reexamination YAMANAKA ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2004/0219892	11-2004	Vaidyanathan et al.	455/103
*	C	US-2003/0206603	11-2003	Husted, Paul J.	375/324
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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